

**Search Notes**

Application/Control No.

10/612,615

Examiner

Tianjie Chen

Applicant(s)/Patent under  
Reexamination

INOUE ET AL.

Art Unit

2656

**SEARCHED**

Class	Subclass	Date	Examiner
369	275.4		
	286		
	280		
	281		
	283	2/10/2006	TJ

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East Reports	2/10/2006	TJ